

AO9926B





General Description

The AO9926B uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V while retaining a 12V $V_{\rm GS(MAX)}$ rating. This device is suitable for use as a uni-directional or bi-directional load switch. Standard Product AO9926B is Pb-free (meets ROHS & Sony 259 specifications). AO9926BL is a Green Product ordering option. AO9926B and AO9926BL are electrically identical.

Features

 $V_{DS}(V) = 20V$

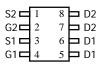
 $I_D = 7.6 \text{ A } (V_{GS} = 10 \text{V})$

 $R_{DS(ON)}$ < 23m Ω (V_{GS} = 10V)

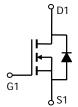
 $R_{DS(ON)}$ < 26m Ω (V_{GS} = 4.5V)

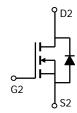
 $R_{DS(ON)}$ < 34m Ω (V_{GS} = 2.5V)

 $R_{DS(ON)}$ < 52m Ω (V_{GS} = 1.8V)



SOIC-8





Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V_{DS}	20	V			
Gate-Source Voltage		V_{GS}	±12	V			
Continuous Drain	T _A =25°C		7.6				
Current ^A	T _A =70°C	I_D	6.1	Α			
Pulsed Drain Current ^B		I _{DM}	30				
	T _A =25°C	P_{D}	2	W			
Power Dissipation A	T _A =70°C		1.28	VV			
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	В	48	62.5	°C/W			
Maximum Junction-to-Ambient ^A	Steady-State	$R_{ hetaJA}$	74	110	°C/W			
Maximum Junction-to-Lead ^C	Steady-State	$R_{ hetaJL}$	35	50	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		20			V
lace	Zero Gate Voltage Drain Current	V _{DS} =16V, V _{GS} =0V				1	
I _{DSS}	Zero Gate Voltage Drain Current		T _J =55°C			5	μΑ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±10V	•			100	nA
BV_GSO	Gate-Source Breakdown Voltage	V _{DS} =0V, I _G =±250uA		±12			V
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} I _D =250uA		0.5	0.8	1	V
$I_{D(ON)}$	On state drain current	V _{GS} =4.5V, V _{DS} =5V		30			Α
R _{DS(ON)} S	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =7.6A			18	23	mΩ
			T _J =125°C		25	30	
		V _{GS} =4.5V, I _D =7A			21	26	mΩ
		V _{GS} =2.5V, I _D =6A			27	34	mΩ
		V_{GS} =1.8V, I_{D} =2A		38	52	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =7.6A			24		S
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.7	1	V
I_S	Maximum Body-Diode Continuous Current					3.5	Α
DYNAMIC	CPARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =10V, f=1MHz			630		pF
Coss	Output Capacitance				164		pF
C_{rss}	Reverse Transfer Capacitance				137		pF
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			1.5		Ω
SWITCHI	NG PARAMETERS						
Q_g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =10V, I _D =7.6A			8.8		nC
Q_{gs}	Gate Source Charge				1		nC
Q_{gd}	Gate Drain Charge				3.7		nC
t _{D(on)}	Turn-On DelayTime				5.5		ns
t _r	Turn-On Rise Time	V_{GS} =5V, V_{DS} =10V, R_L =1.3 Ω , R_{GEN} =3 Ω			14		ns
t _{D(off)}	Turn-Off DelayTime				29		ns
t _f	Turn-Off Fall Time				10.2		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =7.6A, dI/dt=100A/μs			15.2		ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =7.6A, dI/dt=100A/μs			6.3		nC

A: The value of R_{BJA} is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The currentand power rating is based on the 10s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using $80\mu s$ pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

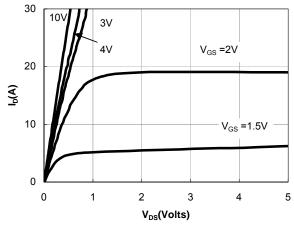


Figure 1: On-Regions CharacteristiCS

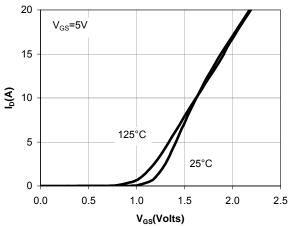


Figure 2: Transfer Characteristics

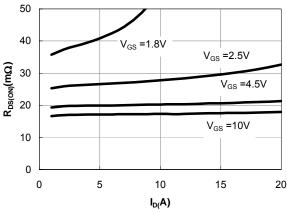


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

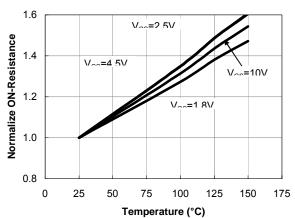


Figure 4: On-Resistance vs. Junction
Temperature

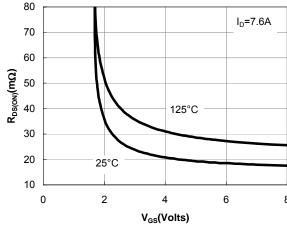


Figure 5: On-Resistance vs. Gate-Source Voltage

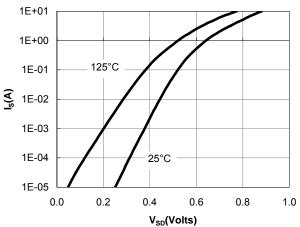


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

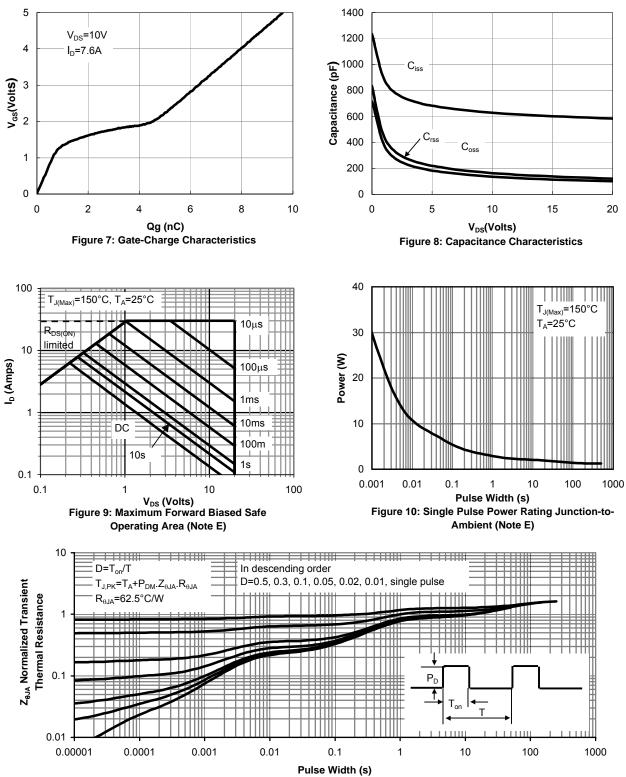


Figure 11: Normalized Maximum Transient Thermal Impedance